

Quantifying Reliability – The Next Step for a Rapidly Maturing PV Industry and China's Role

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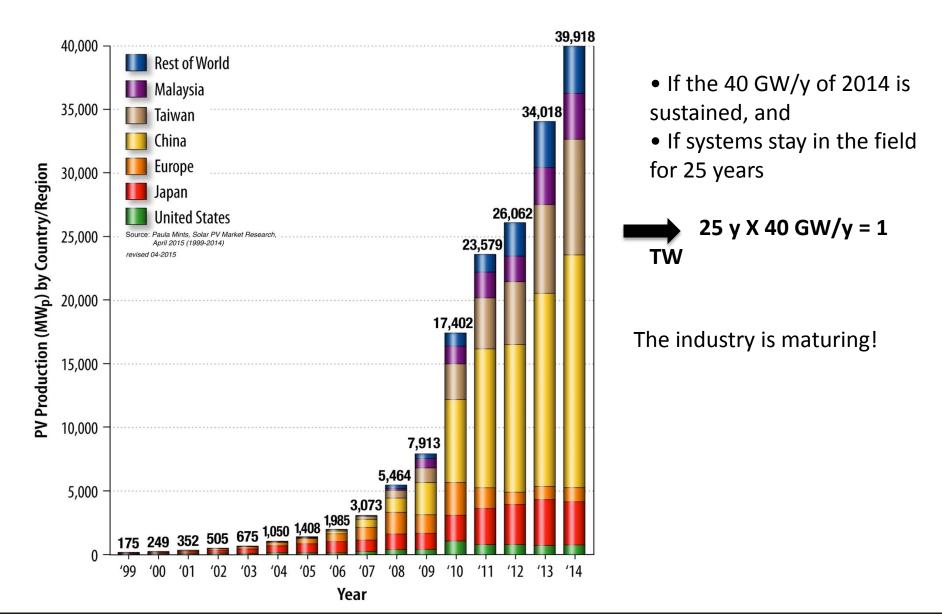
NREL/PR-5J00-65332 NREL is a national laboratory of the U.S. Department of Energy, Office of Energy Efficiency and Renewable Energy, operated by the Alliance for Sustainable Energy, LLC.

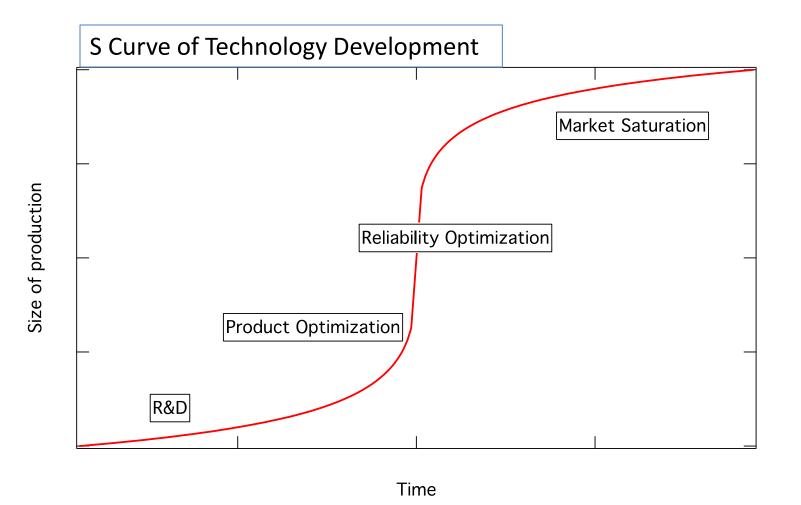
- Optimizing reliability is necessary part of maturation
- A little history origin of today's tests
- Need to quantify value of added reliability to see how much more customers will pay
- Challenges and Progress
- What will it take to reach the end goal of being quantitative?



Why is "Reliability" a hot topic now?

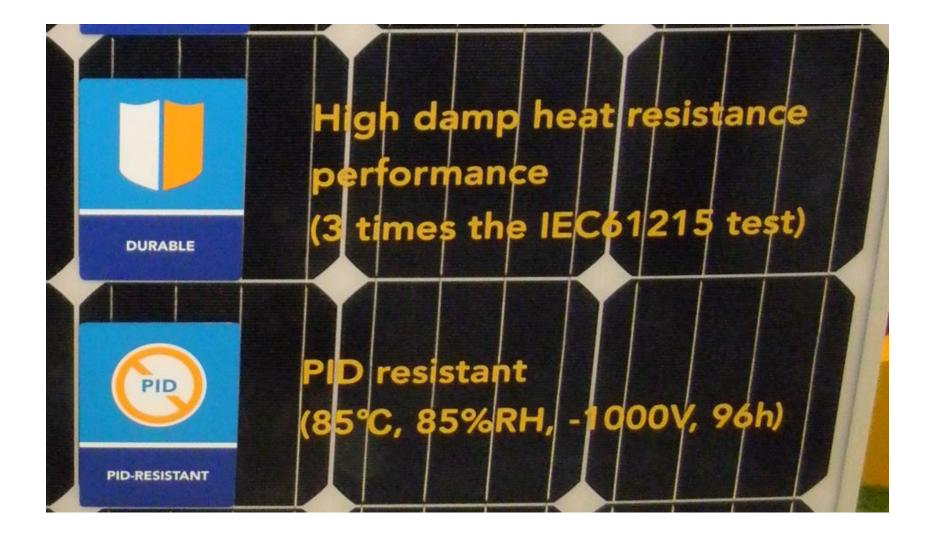
The industry is growing spectacularly!





Reliability is key to continued growth and cost reduction

PV module "features" include reliability



PV module "features" include reliability



Reliable frameless design: Anti-PID, reduced soiling 可靠无边框设计:抗PID,并减少灰尘积累



Fire class A certified 通过防火安全等级A级认证



More durable and resistant to micro-cracks 更耐用并且可以有效防止隐裂



Performs in the most challenging environmental conditions 适用于具有挑战性的严酷环境





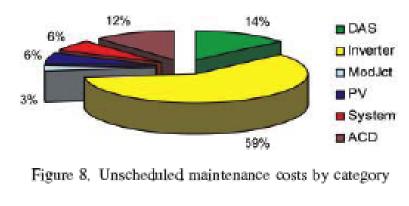
Jet Propulsion Lab (JPL) Block Field Experience

In 1970s a series of "Block Buys":

- A series of PV module buys were used to identify failures.
 - JPL prepared test specification
 - Companies manufactured modules and modified design to pass tests
 - Modules were deployed outdoors
 - If there were field failures, tests were modified and the sequence repeated
- JPL report found "the major cause of module failure to date was by gun shot".
 - Black or blue CZ cells on white background are good targets
 - Squares cells on non-white back sheets reduced problem
- Many early failures were due to cracked cells:
 - Because of module design one cracked cell resulted in total loss of power.
- Non glass superstrate modules suffered from significant soiling and delamination, usually due to UV.

JPL Block Buys led to dramatic improvement

- One study claimed for 1980s modules (Whipple, 1993):
- Pre-Block V: 45% module failure rate
- Post-Block V: <0.1% module failure rate
- Today, most studies (of c-Si modules) show that module failures are small



Similar efforts in Europe also contributed

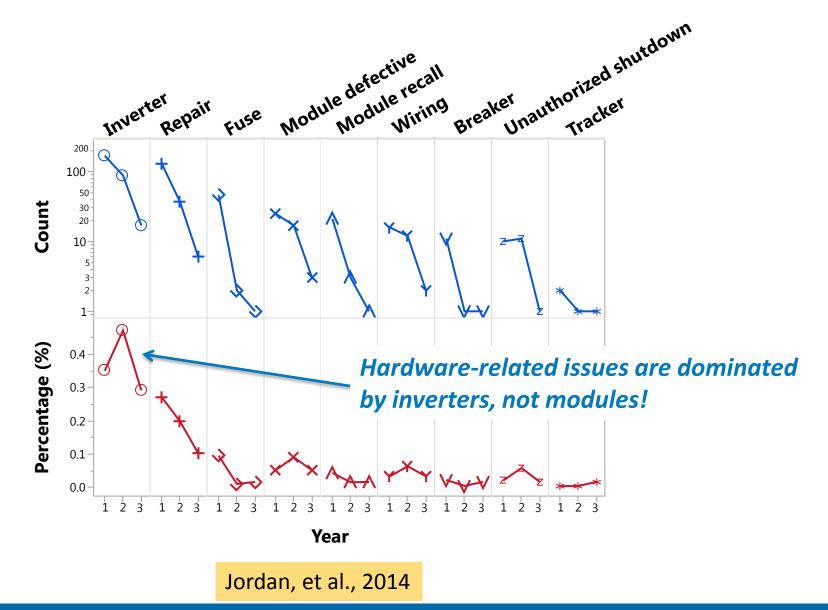
Prog. PV 2008; 16:249

What were the tests that fixed the problems?

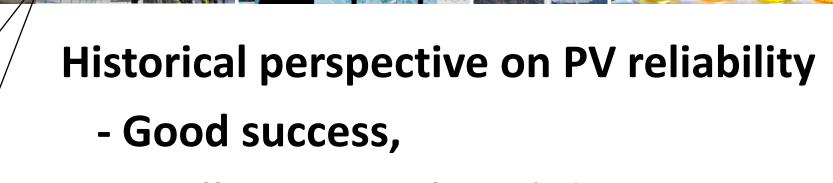
Modules were required to pass a test, then the test was modified to reflect field experience

Test	Block I	Block II	Block III	Block IV	Block V
Thermal	100	50	50	50 —	> 200
Cycles	-40 to +90C	-40 to +90C	-40 to +90C	-40 to +90C	-40 to + 90C
Humidity	70C,90%	5 cycles	5 cycles	5 cycles	10 cycles
	68 hrs	40 C, 90%RH	40 C, 90%RH		<mark>≫85C</mark> , 85%RH
		to -23 C	to -23 C	to -23 C	to -40C
Hot Spot					3 cells
(intrusive)					100 hrs
Mechanical		100 cycles	100 cycles	10000	10000
Load		± 2400 Pa	± 2400 Pa	± 2400 Pa	± 2400 Pa
Hail				9 impacts	10 impacts
				³⁄₄" –45 mph	1" – 52 mph
High Pot		<15 µA	< 50 µA	< 50 µA	< 50 µA
		1500 V	1500 V	1500 V	2*Vs+1000

Analysis of 50,000 systems - Hardware-related Issues







But, still more work to do!

Deficiencies of current qualification tests

• Don't identify all problems

- Cracked cells
- Potential induced degradation
- Damage caused to bypass diodes during manufacturing by electrostatic discharge
- Don't require random sampling
 - IEC 61215 can be completed on one set of hand-picked modules
 - Need to ensure that all modules that are manufactured within the factory's process window will still pass the test
- May not be adequate to test for wear out
 - UV induced discoloration
 - Thermal cycles are not adequate for all locations



If reliability is a "feature" – how much will a customer pay?

...We need to quantify the value of reliability





If a module can pass a "hammer" test..

If a module can pass a more difficult test *without adding cost*

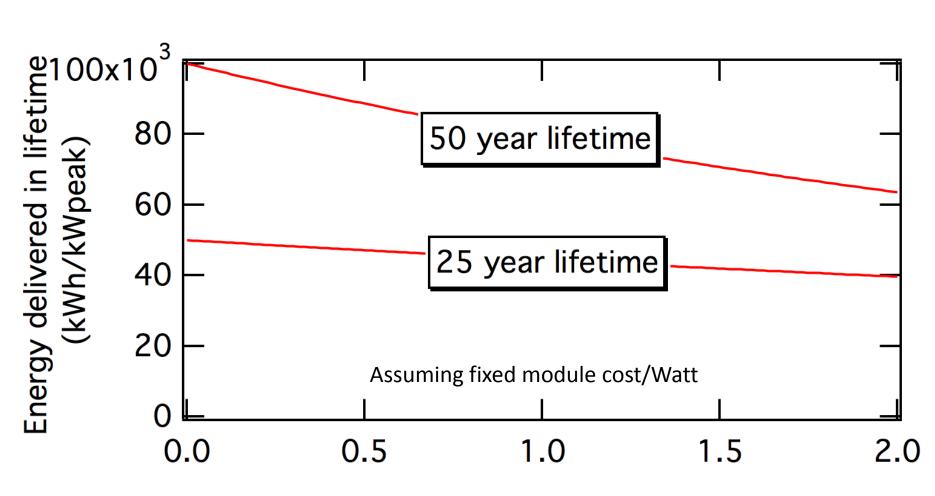
Then, there's no need to quantify the module's properties!!



If it doesn't add cost, then design a module that can pass every "hammer" test and skip trying to quantify the durability/reliability!

Converse: Need to quantify the durability or reliability when "solving" the problem adds cost

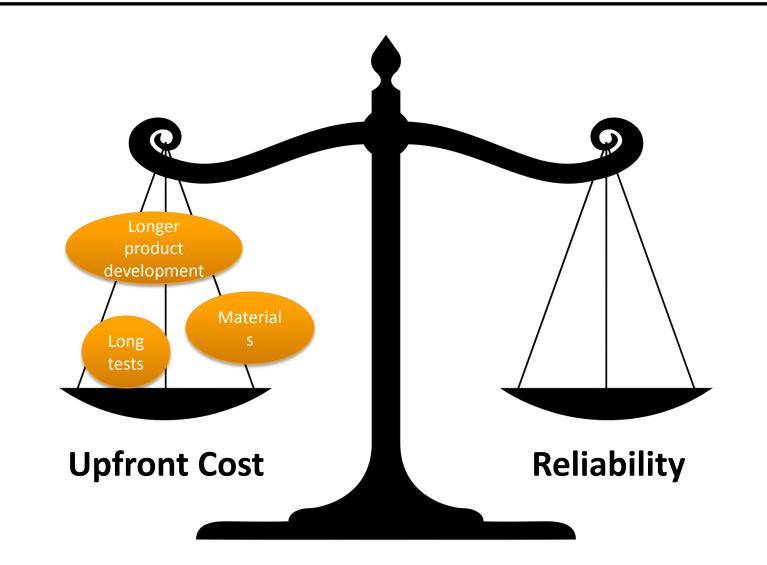
Longer life and less degradation decrease LCOE



Annual linear degradation (%)

LCOE can be decreased by improved module durability, quality, and/or reliability IF the upfront cost does not increase too much!

Optimal balance requires quantification!



Quantify reliability in order to determine how much more we're willing to pay!

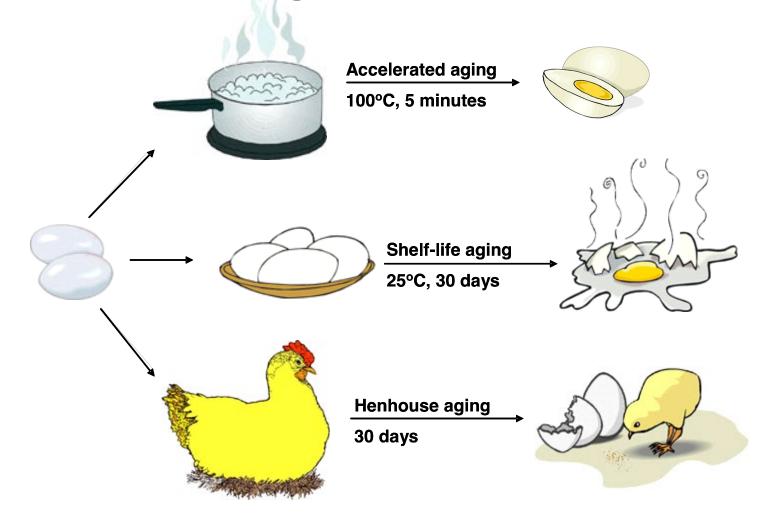
Examples of when added upfront cost is useful

- Strength to withstand snow & ice justifies added cost of stronger frame or glass
- Potential induced degradation (PID) can be avoided, but there is a cost or efficiency penalty
- Excellent quality management system reduces number of recalls and returns
- How much more will a customer pay?



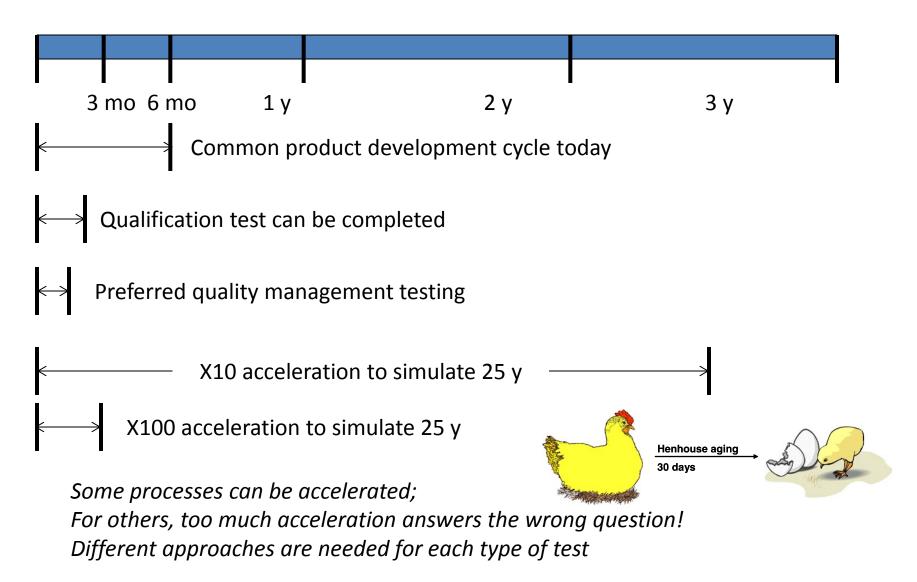


Accelerating 25 y into 3 months is like hatching a chick in 6 hours!



Some processes cannot be accelerated quantitatively > 10X

Timeline Challenge



Challenges to quantifying reliability

- Long desired service life (>25 y)
- Rapidly evolving product designs (< 6 months?)
- Complexity of use environments
- High cost of testing for large sample sets

• Many ways a module may fail





Requires international solution!

- Many local organizations are working on aspects of improving reliability and bankability
- Two international organizations will be described today
 - IEC (International Electrotechnical Commission)
 - PVQAT (International PV Quality Assurance Task Force)

IEC (International Electrotechnical Commission)

- Technical Committee 82 (Solar PV Energy Systems)
 - Has written IEC 61215, IEC 61730, etc.
 - More than 80 documents are currently being developed or revised by TC 82.

• IECRE

- Under IEC's Conformity Assessment Board (CAB)
- System-level certification to consensus standards, including:
 - Component durability and quality
 - System design, installation, operation, maintenance
 - System performance

PVQAT (International PV Quality Assurance Task Force)

- Formed in 2011, inspired by METI in Japan
- Informal organization encourages participation by all
- Emphasis on organizing and sharing research results toward how to test for different:
 - Climates
 - Mounting configurations
- <u>www.PVQAT.org</u> (English)
- <u>www.PVQAT.com</u> (Chinese)

PVQAT (International PV Quality Assurance Task Force)

	25	PVQA Internatio	_	Search PVQAT	SEARCH	
HOME A	BOUT	PROJECT STA	TUS RESOURC	es events	CONTACTS	
The International PV Quality Assurance Task Force (PVQAT, "PV cat") leads global efforts to craft quality and reliability standards including: MODULE MANUFACTURING SYSTEM DURABILITY CONSISTENCY VERIFICATION				Sign Up fo	STAY UPDATED Sign Up for Our Mailing List PVQAT Timeline	
A rating system to ensure durable design of PV modules for the climate and application of interest	A guideline inspections assurance module ma	and quality (QA) during	A comprehensive syste for certification of P systems, verifying appropriate design,	Active Control of Cont	Image: state	
			installation, and operation	ion	Click to Enlarge	

Consistent Manufacturing – Quality Control



Updated Proposal for a Guide for Quality Management Systems for PV Manufacturing: Supplemental Requirements to ISO 9001-2008

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 ³ Trina Solar
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 ⁵ First Solar
 ⁶ Mitsui Chemical
 ⁷ Amonix
 ⁸ National Renewable Energy Laboratory

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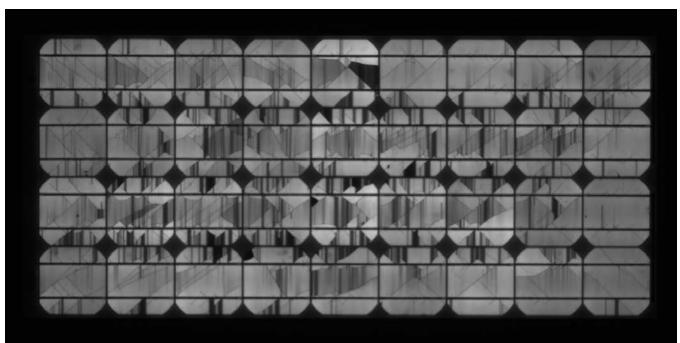
This report is available at no cost from the National Renewable Energy Laboratory (NREL) at www.nrel.gov/publications.

Technical Report NREL/TP-5J00-63742 March 2015

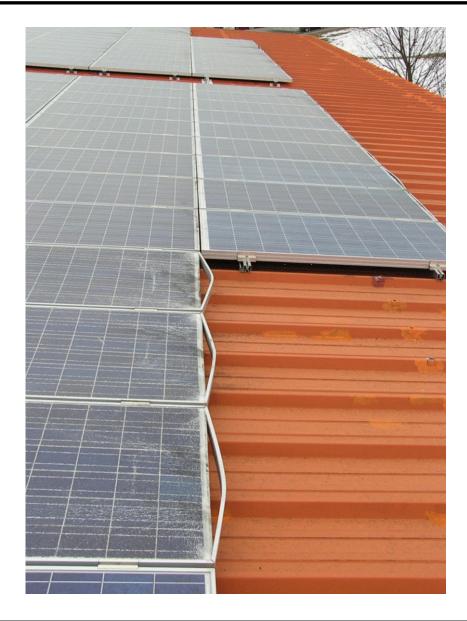
Contract No. DE-AC36-08GO28308

- PVQAT has written a PVspecific version of ISO 9001
- Focus is on aligning the QMS with the customers' needs such as:
 - Power rating
 - Warranty
- IEC is preparing it for publication (IEC 62941)
- Description is on-line: <u>www.nrel.gov/docs/fy15osti/63</u> <u>742.pdf</u>

- Qualification test: Edition 3 of IEC 61215
 - Unifies IEC 61215 (silicon) and IEC 61646 (thin films)
 - Improved hot-spot test
 - Amendments planned to include
 - Test to identify susceptibility to power loss from cracked cells



- Potential-induced degradation (PID) test: IEC 62804 (two test methods)
- Snow and ice: IEC
 62938

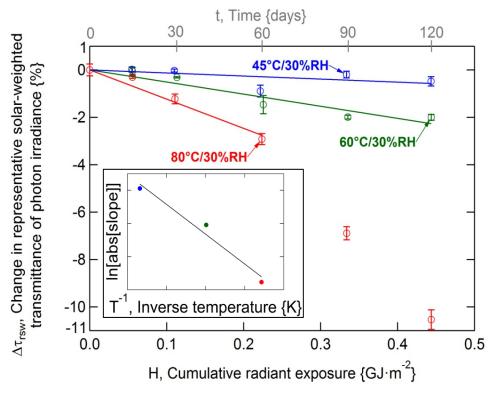


- Safety for modules Edition 2 of IEC 61730
 - $_{\odot}$ Will enable harmonization with UL1703
 - Amendment will include:
 - UV weathering test
- UV durability test IEC 62788-7-2 (and others)
 Will include encapsulants, backsheets, etc.
- System level tests
 - Performance (IEC 61724-1 measurement, -2 power, -3 energy)
 - Commissioning, design, maintenance, etc.

Kelly, et al, PVSC 2015 (Monday)

Recent progress - studies

 PVQAT study quantifies temperature dependence of UV-induced discoloration



Miller, et al, PVSC 2015



What will it take to reach the end goal of being quantitative?

Service Life Prediction Standard?

- How would you write a standard for making a Service Life Prediction?
- The failure mechanisms that limit the life of a product may vary
- Current research is providing scientific basis, but we don't have a draft standard yet

Steps to a Service Life Prediction:

- 1. Identify failure/degradation mechanisms that determine end of life
- 2. Quantify kinetic rates
- 3. For given use environment, apply kinetic rates within model to estimate expected lifetime
- 4. Verify model by comparing with field data

This step-by-step procedure is clear, but the actual tests are not

This procedure is similar to quality management

First must understand:

- Degradation/failure mechanisms
 May differ by location
 May involve a series of stresses
- How to test for these in quantitative way Need to know kinetics May involve a series of stresses

In addition to understanding:

- Degradation/failure mechanisms
- How to test for these in quantitative way

We require:

- 1) Specific use environment
- 2) Specific bill of materials
- 3) Defined process window

Why use environment must be defined

 A test that predicts 25 years in Munich may only predict ~ 2 years in Phoenix! (assumes failure is caused by higher temperature with an activation energy of 1.1 eV)

Kurtz, et al, Progress in PV 2011, p 954

Why bill of materials must be controlled

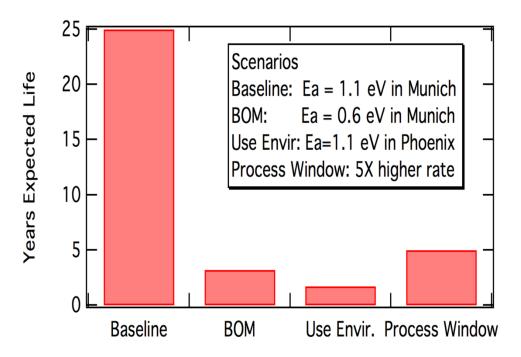
- A change in the bill of materials (BOM) may change the chemical composition
- An example of possible problem:
 - Additives in encapsulants affect the discoloration mechanism
 - Some mechanisms are accelerated by temperature more than others
 - If the activation energy changes from 1.1 eV to 0.6 eV, the acceleration factor could change by a factor of ~10
 - A test that predicts 25 years could unknowingly predict only ~ 3 years!

Why process window must be defined

- Variations in the product may cause premature failure
- An example of possible problem:
 - 90% of solder bonds use solder coatings 0.2 mm thick, but sometimes the solder application varies and the thickness drops as low as 0.04 mm.
 - Thermal fatigue occurs faster in the thinner bond (the lifetime is roughly proportional to the thickness)
 - The test may predict 25 years for the product with 0.2 mm solder, but products accidentally made with only 0.04 mm solder might fail after 5 years!
 - The test should be designed so that all products falling within the process window will have the intended lifetime.

A prediction needs to have a low uncertainty

• A prediction of a lifetime isn't worth much if the uncertainty is a factor of 10!



The uncertainty may be unknown and large if we haven't controlled the use environment, the BOM, and the process window.

Challenge for the world and role for China

Big job!!

- Identify all failure modes
- Quantify rates of degradation/failure
- All countries need to work together

• China has a lot to contribute!

- Biggest manufacturer understand quality control
- Biggest customer understand field experience for a range of climates

Conclusions

- What reliability issues need to be quantified?
 Ones that can't be solved without increasing cost
- What are strategies for quantitative testing?
 - Test materials: long tests may be used to qualify the material before incorporation into modules
 - Detailed understanding of failure mechanisms is needed to design tests:
 - Quickly identify lack of susceptibility
 - Less quickly quantify rate if there is susceptibility
 - Random testing from production line
 - Differentiate climate-specific durability
- What will it take to reach the end goal of being quantitative?

• Defined use environment, BOM, process window

PV industry is making great progress toward improved prediction of long-term reliability!

International standards are being developed by IEC with support from PVQAT

Special thanks to the hundreds of individuals who are contributing to this work!

Thank you for your attention!

